## Notice of References Cited Application/Control No. 10/799,855 Examiner Binh V. Ho Applicant(s)/Patent Under Reexamination TAKEDA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
Ĭ	Α	US-2002/0047533	04-2002	Fushimi et al.	315/82
	В	US-2004/0036418	02-2004	Rooke et al.	315/77
	С	US-2003/0123705	07-2003	Stam et al.	382/104
	D	US-			
	Ε	US-			
	F	US-			
	G	US-	<del>.</del>		
	Н	US-		·	
	ı	US-			- <del></del>
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	·				
	0					
	Р					
	Q					
	R					
	s					
	Т	·			•	

## **NON-PATENT DOCUMENTS**

TOTAL POSSIBLE OF							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	٧						
	w						
	х						

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.